

Notice of References Cited	Application/Control No. 10/792,251	Applicant(s)/Patent Under Reexamination WON ET AL.	
	Examiner Faye Francis	Art Unit 3712	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0139276 A1	07-2003	Lozano, Hector	493/480
	B	US-6,059,708 A	05-2000	Armendariz et al.	493/223
	C	US-6,354,904 B1	03-2002	Grey et al.	446/5
	D	US-5,242,308 A	09-1993	Estrada, Luis I.	434/365
	E	US-5,906,530 A	05-1999	Lindsey, Alan	446/85
	F	US-5,536,194 A	07-1996	Larsen et al.	446/5
	G	US-4,793,546	12-1988	Nunn, Gary L.	229/109
	H	US-3,983,658	10-1976	de Sanz, Enrique Sort	446/5
	I	US-3,702,675	11-1972	Bajo	446/5
	J	US-4,787,872	11-1988	Bajo, Ricardo	446/5
	K	US-D178,024	06-1956	Swann	D11/121
	L	US-4,015,364	04-1977	Oquita, Ramiro	446/5
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/16002 A1	02-2002	WO		
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.